

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/591,987 YASUDA ET AL.	
		Examiner	Art Unit ANKUSH k. SINGAL	2895 Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,245,622 A	09-1993	Jewell et al.	372/45.01
*	B	US-5,251,225 A	10-1993	Eglash et al.	372/45.01
*	C	US-5,541,949 A	07-1996	Bhat et al.	372/45.011
*	D	US-5,617,436 A	04-1997	Lo, Yu-Hwa	372/45.011
*	E	US-5,719,891 A	02-1998	Jewell, Jack L.	372/46.013
*	F	US-5,883,912 A	03-1999	Ramdani et al.	372/45.01
*	G	US-5,900,642 A	05-1999	Nakatsu et al.	257/25
*	H	US-5,959,401 A	09-1999	Asami et al.	313/503
*	I	US-5,963,576 A	10-1999	Claisse et al.	372/96
*	J	US-5,991,326 A	11-1999	Yuen et al.	372/96
*	K	US-6,130,780 A	10-2000	Joannopoulos et al.	359/584
*	L	US-2001/0050934 A1	12-2001	Choquette et al.	372/43
*	M	US-2002/0034203 A1	03-2002	Shimizu et al.	372/45

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YASUDA ET AL.	
		Examiner ANKUSH k. SINGAL	Art Unit 2895	Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0053676 A1	05-2002	Kozaki, Tokuya	257/88
*	B	US-2002/0071471 A1	06-2002	Kim et al.	372/96
*	C	US-6,434,178 B1	08-2002	Ubukata, Akinori	372/45.011
*	D	US-6,486,491 B1	11-2002	Najda, Stephen Peter	257/18
*	E	US-6,489,175 B1	12-2002	Jiang et al.	438/29
*	F	US-2002/0196827 A1	12-2002	Shields et al.	372/45
*	G	US-2003/0006409 A1	01-2003	Ohba, Yasuo	257/18
*	H	US-2003/0091085 A1	05-2003	Northrup et al.	372/50
*	I	US-2003/0116767 A1	06-2003	Kneissl et al.	257/79
*	J	US-2003/0178629 A1	09-2003	Yagi, Shigeru	257/87
*	K	US-2003/0183827 A1	10-2003	Kawaguchi et al.	257/79
*	L	US-2003/0205736 A1	11-2003	Kozaki, Tokuya	257/200
*	M	US-2003/0235229 A1	12-2003	Deng et al.	372/96

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YASUDA ET AL.	
		Examiner ANKUSH k. SINGAL	Art Unit 2895	Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,683,898 B2	01-2004	.O slashed.stergaard et al.	372/43.01
*	B	US-6,711,195 B2	03-2004	Chang et al.	372/45.01
*	C	US-6,709,881 B2	03-2004	Hasegawa et al.	438/24
*	D	US-2004/0155250 A1	08-2004	Ohba, Yasuo	257/079
*	E	US-6,800,878 B2	10-2004	Nambu et al.	257/194
*	F	US-6,801,558 B2	10-2004	Burak, Dariusz	372/50.11
*	G	US-2004/0219699 A1	11-2004	Koyama et al.	438/022
*	H	US-6,821,800 B2	11-2004	Koide et al.	438/22
*	I	US-6,931,044 B2	08-2005	Bour et al.	372/46.01
*	J	US-6,975,660 B2	12-2005	Johnson, Ralph H.	372/45.01
*	K	US-6,993,055 B2	01-2006	Wang et al.	372/46.013
*	L	US-7,190,001 B2	03-2007	Taki, Tetsuya	257/79
*	M	US-7,263,114 B2	08-2007	Cho, Soo-haeng	372/45.01

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No. 10/591,987	Applicant(s)/Patent Under Reexamination YASUDA ET AL.	
		Examiner ANKUSH k. SINGAL	Art Unit 2895	Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,254,155 B1	08-2007	Deng et al.	372/97
*	B	US-7,282,732 B2	10-2007	Gray et al.	257/14
*	C	US-7,358,522 B2	04-2008	Yanamoto, Tomoya	257/14
*	D	US-7,378,680 B2	05-2008	Johnson et al.	257/11
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.